

<b>Notice of References Cited</b>	Application/Control No. 10/817,363	Applicant(s)/Patent Under Reexamination EUN J. RHEE ET AL.	
	Examiner THUAN T. NGUYEN	Art Unit 2618	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,123,910 B2	10-2006	Lucidarme et al.	455/434
*	B	US-2004/0147262 A1	07-2004	Lescuyer et al.	455/434
	C	US-			
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	F	US-			
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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